


<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>	
	10/560,930	AMAMIYA, YASUSHI	
	<b>Examiner</b>	<b>Art Unit</b>	
	An T. Luu	2816	

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EASY - Text Search - 327/208,210-212,214-219,199,202-204 and keywords	8/13/2007	ATL